TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62591AP,TD62592AP,TD62593AP,TD62594AP TD62595AP,TD62595AF,TD62596AP,TD62596AF TD62597AP,TD62597AF,TD62598AP,TD62598AF

8CH SINGLE DRIVER

The TD62591AP Series are comprised of eight NPN Transistor Arrays.

Applications include relay, hammer, lamp and display (LED) drivers.

FEATURES

- Output current (single output) 200 mA (max)
- High sustaining voltage output 50V (min)
- Low saturation voltage V_{CE} (sat) = 0.8 V @Iout = 150mA inputs compatible with various type logic.
- Include Input Resistor

TD62591, TD62595AP, TD62595AF: external.

general purpose

TD62592, TD62596AP, TD62596AF: 10.5 kΩ + 7V

zener diode 14~25 V

PMOS

TD62593, TD62597AP, TD62597AF : 2.7 k Ω

TTL, 5 V CMOS

TD62594, TD62598AP, TD62598AF : 10.5 k Ω

6~15 V PMOS, CMOS

• Include Clamp Diode

TD62595AP, TD62595AF, TD62596AP, TD62596AF TD62597AP, TD62597AF, TD62598AP, TD62598AF

Package type-AP : DIP-18pinPackage type-AF : SOP-18pin

DIP18-P-300-2.54D TD62595AF TD62596AF TD62597AF TD62598AF SOP18-P-375-1.27

TD62591AP, TD62592AP, TD62593AP

TD62594AP, TD62595AP, TD62596AP

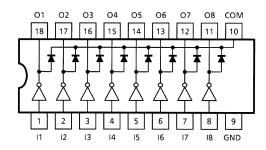
TD62597AP, TD62598AP

Weight DIP18-P-300-2.54D: 1.47 g (typ.) SOP18-P-375-1.27: 0.5 g (typ.)

PIN CONNECTION (TOP VIEW)

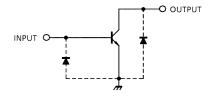
TD62591AP, TD62592AP, TD62593AP, TD62594AP

02 03 04 05 06 07 08 NC 18 17 16 15 14 13 12 11 10 2 3 4 5 6 7 8 13 15 12 16 17 GND TD62595AP, TD62595AF, TD62596AP, TD62596AF TD62597AP, TD62597AF, TD62598AP, TD62598AF

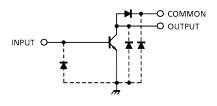


SCHEMATICS (EACH DRIVER)

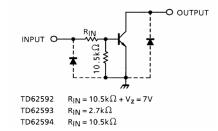
TD62591AP



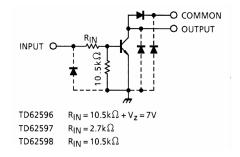
TD62595AP, TD62595AF



TD62592AP, TD62593AP, TD62594AP



TD62596AP, TD62596AF, TD62597AP, TD62597AF, TD62598AF, TD62598AF



Note: The input and output parasitic diodes cannot be used as clamp diodes.

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Emitter Voltage	V _{CEO}	50	V
Collector-Base Voltage	V _{CBO}	50	V
Clamp Diode Reverse Voltage	V _R (Note 1)	50	٧
Collector Current	IC	200	mA / ch
Input Voltage	V _{IN} (Note 2)	-0.5~30	٧
Input Current	I _{IN} (Note 3)	25	mA
Power Dissipation	P _D (Note 4)	0.96 (Note 5) / 1.47	W
Operating Temperature	T _{opr}	-40~85	°C
Storage Temperature	T _{stg}	-55~150	°C

Note 1: Except TD62591~TD62594AP

Note 2: Except TD62591AP, TD62595AP, TD62595AF

Note 3: Only TD62591AP, TD62595AP, TD62595AF

Note 4: Delated above 25 $^{\circ}$ C in the proportion of 11.7mW / $^{\circ}$ C (AP-Type), 7.7mW / $^{\circ}$ C (F, AF-Type)

2

Note 5: SOP-18pin



RECOMMENDED OPERATING CONDITIONS (Ta = $-40\sim85^{\circ}$ C)

CHARAC	TERISTIC	SYMBOL	CONDITION	MIN	TYP.	MAX	UNIT
Collector-Emitter \	/oltage	V _{CEO}	_	0	_	50	V
Collector-Base Vo	Itage	V _{CBO}	_	0	_	50	V
Collector Current		Ic	-	0	_	150	mA / ch
Clamp Diode Reve	rse Voltage	V _R	(Note1)	7	_	50	V
Input Voltage		V _{IN}	(Note2)	0	_	25	V
Input Current		I _{IN}	(Note3)	0	_	10	mA
Input Voltage (Output On)	TD62592 TD62596	Vin (on)	_	14.0	_	25	
	TD62593 TD62597			2.4	_	25	V
	TD62594 TD62598			7.0	_	25	
Power Dissipation	AP	- P _D	_	_	_	0.52	W
	AF		_	_	_	0.355	VV

ELECTRICAL CHARACTERISTICS (Ta = 25°C unless otherwise noted)

CHARA	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN	TYP.	MAX	UNIT
Output Leakage	Current	I _{CEX}	1	V _{CE} = 50 V, V _{IN} = 0		_	_	10	μΑ
Collector-Emitter Saturation Voltage		V _{CE (sat)}	2	I _C = 10 mA, I _{IN} = 0.4 mA		_	_	0.2	V
				I _C = 150 mA, I _{IN} = 3.0 mA		_	_	0.8	
DC Current Transfer Ratio		h _{FE}	2	V _{CE} = 10 V I _C = 10 mA	(Note 3)	70	_	_	_
					(Note 2)	50	_	_	
TD6258 T	TD62591 TD62595	- I _{IN (ON)} 3		I _C = 50 mA		_	_	0.65	
	TD62592 TD62596		N) 3	V _{IN} = 14V, I _C = 50 mA		_	_	0.9	mA
	TD62593 TD62597			V _{IN} = 2.4 V, I _C = 50 mA		_	_	0.9	IIIA
	TD62594 TD62598			V _{IN} = 7.0 V, I _C = 50 mA		_	_	0.9	
Turn-On Delay		ton	4	V _{OUT} = 50 V, R _I = 330 Ω		_	0.1		μs
Turn-Off Delay		t _{OFF}	7	VOUT - 30 V, KL - 330 12		_	0.3	_	μs

Note 1: Except TD62591~TD62594AP

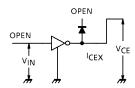
Note 2: Except TD62591AP, TD62595AP, TD62595AF Note 3: Only TD62591AP, TD62595AP, TD62595AF

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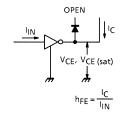


TEST CIRCUIT

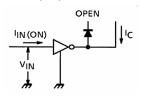
1. I_{CEX}



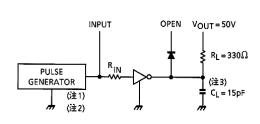
2. h_{FE}, V_{CE (sat)}

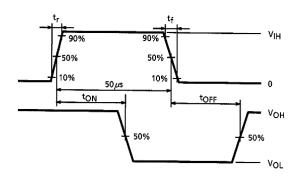


3. V_{IN (ON)}



4. ton, toff





Note 1: Pulse width 50 µs, duty cycle 10%

Output impedance 50 Ω , $t_{\Gamma} \le 5$ ns, $t_f \le 10$ ns

Note 2: See below

Input Condition

TYPE NUMBER	R _{IN}	V _{IH}
TD62591AP, TD62595AP, TD62595AF	2.7 kΩ	3 V
TD62592AP, TD62596AP, TD62596AF	0 Ω	15 V
TD62593AP, TD62597AP, TD62597AF	0 Ω	3 V
TD62594AP, TD62598AP, TD62598AF	0 Ω	10 V

Note 3: C_L includes probe and jig capacitance

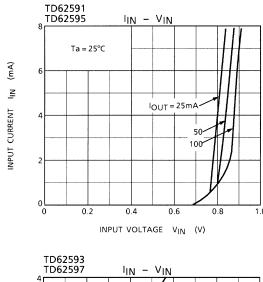
PRECAUTIONS for USING

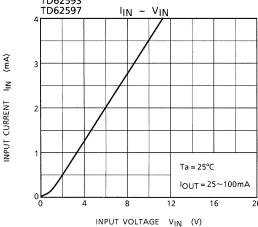
This IC does not integrate protection circuits such as overcurrent and overvoltage protectors.

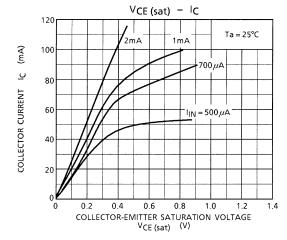
Thus, if excess current or voltage is applied to the IC, the IC may be damaged. Please design the IC so that excess current or voltage will not be applied to the IC.

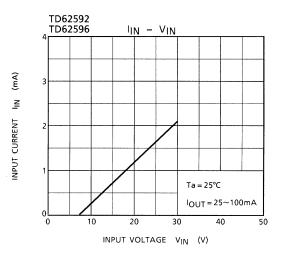
Utmost care is necessary in the design of the output line, $V_{\rm CC}$ and GND line since IC may be destroyed due to short–circuit between outputs, air contamination fault, or fault by improper grounding.

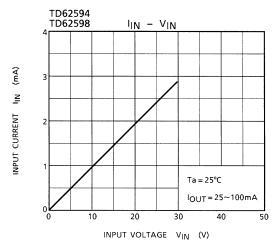
4

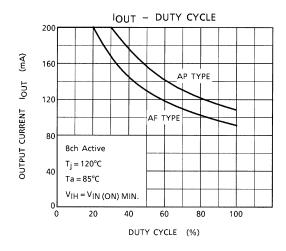


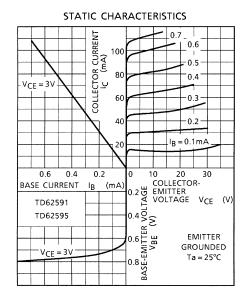


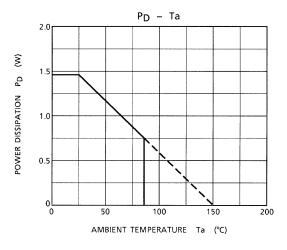


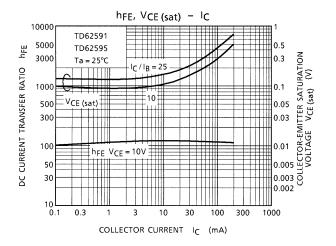












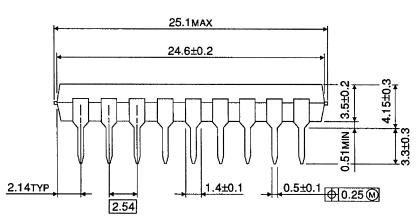
PACKAGE DIMENSIONS

DIP18-P-300-2.54D

7.62

6.4±0.2

Unit: mm



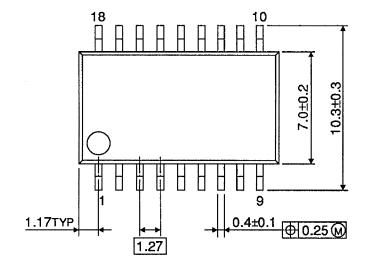
7

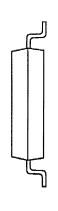
Weight: 1.47 g (typ.)

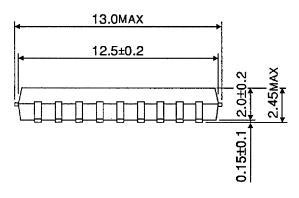
PACKAGE DIMENSIONS

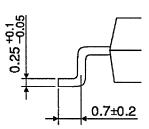
SOP18-P-375-1.27

Unit: mm









Weight: 0.50 g (typ.)



Notes on Contents

1. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

2. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

IC Usage Considerations

Notes on Handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
 Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.

 Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly. Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion. In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.

 If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.



Points to Remember on Handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (Tj) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.

(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

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